

## Is Now Part of



# ON Semiconductor®

# To learn more about ON Semiconductor, please visit our website at www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to Fairchild <a href="general-regarding-numbers-n

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officer



ON Semiconductor®

February 2017

# FGH75T65SQDTL4 650 V, 75 A Field Stop Trench IGBT

#### **Features**

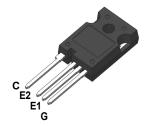
- Maximum Junction Temperature: T<sub>J</sub> = 175°C
- · Positive Temperature Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage: V<sub>CE(sat)</sub> = 1.6 V (Typ.) @ I<sub>C</sub> = 75 A
- 100% of the Parts tested for I<sub>LM</sub>(1)
- · High Input Impedance
- · Fast Switching
- · Tighten Parameter Distribution
- · RoHS Compliant

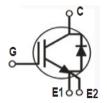
## **General Description**

Using novel field stop IGBT technology, ON semiconductor's new series of field stop 4<sup>th</sup> generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

# **Applications**

· Solar Inverter, UPS, Welder, Telecom, ESS, PFC





E1: Kelvin Emitter **E2: Power Emitter** 

# **Absolute Maximum Ratings**

Symbol	Description		FGH75T65SQDTL4	Unit
V <sub>CES</sub>	Collector to Emitter Voltage		650	V
V <sub>GES</sub>	Gate to Emitter Voltage		± 20	V
	Transient Gate to Emitter Voltage		± 30	V
Ic	Collector Current	@ T <sub>C</sub> = 25°C	150	Α
iC	Collector Current	@ T <sub>C</sub> = 100°C	75	Α
I <sub>LM</sub> (1)	Pulsed Collector Current	@ T <sub>C</sub> = 25°C	300	Α
I <sub>CM</sub> (2)	Pulsed Collector Current		300	Α
I <sub>F</sub>	Diode Forward Current	@ T <sub>C</sub> = 25°C	125	Α
'F	Diode Forward Current	@ T <sub>C</sub> = 100°C	75	Α
I <sub>FM</sub>	Pulsed Diode Maximum Forward Current		300	Α
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	375	W
י ט	Maximum Power Dissipation	@ T <sub>C</sub> = 100°C	188	W
T <sub>J</sub>	Operating Junction Temperature		-55 to +175	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +175	°C
T <sub>L</sub>	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

<sup>1.</sup>  $V_{\rm CC}$  = 400 V,  $V_{\rm GE}$  = 15 V,  $I_{\rm C}$  = 300 A,  $R_{\rm G}$  = 26.4  $\Omega$ , Inductive Load 2. Repetitive rating: Pulse width limited by max. junction temperature

# **Thermal Characteristics**

Symbol	Parameter	FGH75T65SQDTL4	Unit
R <sub>θJC</sub> (IGBT)	Thermal Resistance, Junction to Case, Max.	0.4	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case, Max.	0.65	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	°C/W

# **Package Marking and Ordering Information**

<b>Device Marking</b>	Device	Package	Reel Size	Tape Width	Qty per Tube
FGH75T65SQDTL4	FGH75T65SQDTL4	TO-247 A04	-	-	30

# Electrical Characteristics of the IGBT $T_C = 25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	650	-	-	V
ΔBV <sub>CES</sub> / ΔΤ <sub>J</sub>	Temperature Coefficient of Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	-	0.6	-	V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	250	μΑ
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = V_{GES}$ , $V_{CE} = 0 V$	-	-	± 400	nA
On Charac	teristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	I <sub>C</sub> = 75 mA, V <sub>CE</sub> = V <sub>GE</sub>	2.6	4.5	6.4	V
()		I <sub>C</sub> = 75 A, V <sub>GE</sub> = 15 V	-	1.6	2.1	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	I <sub>C</sub> = 75 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 175°C	-	1.92	-	٧
Dynamic C	haracteristics			•		
C <sub>ies</sub>	Input Capacitance		-	4845	-	pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$ f = 1  MHz	-	155	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	- 1 - 1 WITZ	-	14	-	pF
Switching	Characteristics			•		
T <sub>d(on)</sub>	Turn-On Delay Time		-	44	_	ns
T <sub>r</sub>	Rise Time		-	20	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 18.8 A,	-	276	-	ns
T <sub>f</sub>	Fall Time	$R_G = 15 \Omega, V_{GE} = 15 V,$	-	32	-	ns
E <sub>on</sub>	Turn-On Switching Loss	Inductive Load, T <sub>C</sub> = 25°C	-	307	-	μJ
E <sub>off</sub>	Turn-Off Switching Loss		-	266	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	573	-	μJ
T <sub>d(on)</sub>	Turn-On Delay Time		-	44	-	ns
T <sub>r</sub>	Rise Time		-	32	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time	$V_{CC}$ = 400 V, $I_{C}$ = 37.5 A, $R_{G}$ = 15 $\Omega$ , $V_{GE}$ = 15 V, Inductive Load, $T_{C}$ = 25°C	-	264	-	ns
T <sub>f</sub>	Fall Time		-	28	-	ns
E <sub>on</sub>	Turn-On Switching Loss		-	599	-	μJ
E <sub>off</sub>	Turn-Off Switching Loss		-	608	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	1207	-	μJ

# **Electrical Characteristics of the IGBT** (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
T <sub>d(on)</sub>	Turn-On Delay Time		-	40	-	ns
T <sub>r</sub>	Rise Time		-	24	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 18.8 A,	-	316	-	ns
T <sub>f</sub>	Fall Time	$R_G = 15 \Omega$ , $V_{GE} = 15 V$ ,	-	36	-	ns
E <sub>on</sub>	Turn-On Switching Loss	Inductive Load, T <sub>C</sub> = 175°C	-	730	-	μJ
E <sub>off</sub>	Turn-Off Switching Loss		-	408	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	1138	-	μJ
T <sub>d(on)</sub>	Turn-On Delay Time		-	44	-	ns
T <sub>r</sub>	Rise Time		-	36	-	ns
$T_{d(off)}$	Turn-Off Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 37.5 A,	-	296	-	ns
T <sub>f</sub>	Fall Time	$R_G = 15 \Omega$ , $V_{GE} = 15 V$ ,	-	32	-	ns
E <sub>on</sub>	Turn-On Switching Loss	Inductive Load, T <sub>C</sub> = 175°C	-	1240	-	μJ
E <sub>off</sub>	Turn-Off Switching Loss		-	853	-	μJ
E <sub>ts</sub>	Total Switching Loss		-	2093	-	μJ
Qg	Total Gate Charge		-	128	-	nC
Q <sub>ge</sub>	Gate to Emitter Charge	$V_{CE} = 400 \text{ V}, I_{C} = 75 \text{ A},$ $V_{GE} = 15 \text{ V}$	-	23	-	nC
Q <sub>gc</sub>	Gate to Collector Charge		-	29	-	nC

# Electrical Characteristics of the Diode $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V <sub>FM</sub>	Diode Forward Voltage	I <sub>E</sub> = 75 A	T <sub>C</sub> = 25°C	-	1.8	2.1	V
Diode Forward Voltage	F - 10 A	T <sub>C</sub> = 175°C	-	1.7	-		
E <sub>rec</sub>	Reverse Recovery Energy		T <sub>C</sub> = 175°C	-	160	-	μJ
T <sub>rr</sub>	Diode Reverse Recovery Time	   I <sub>F</sub> = 75 A, dI <sub>F</sub> /dt = 200 A/μs	T <sub>C</sub> = 25°C	-	76	-	ns
	place reverse recovery rime	- 13 A, αιτ/αι - 200 A/μ3	T <sub>C</sub> = 175°C	-	270	-	110
Q <sub>rr</sub>	Diode Reverse Recovery Charge		T <sub>C</sub> = 25°C	-	206	-	nC
~11	2.535 No. 5.55 No. 50 No. 19		T <sub>C</sub> = 175°C	-	2199	-	

**Figure 1. Typical Output Characteristics** 

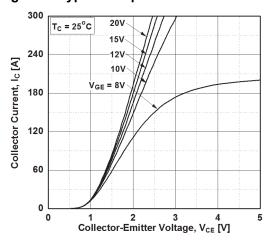


Figure 3. Typical Saturation Voltage Characteristics

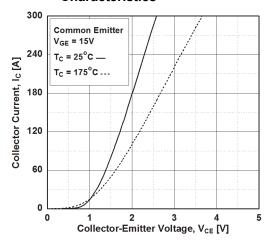


Figure 5. Saturation Voltage vs. V<sub>GE</sub>

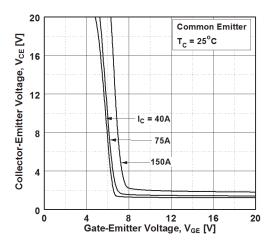


Figure 2. Typical Output Characteristics

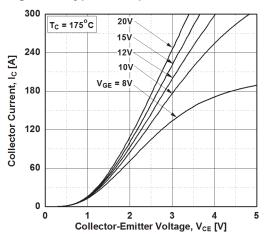


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

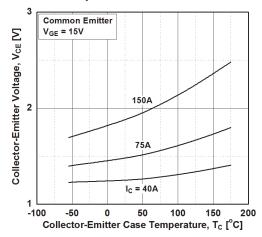


Figure 6. Saturation Voltage vs.  $V_{GE}$ 

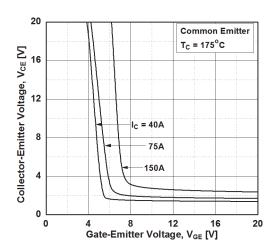


Figure 7. Capacitance Characteristics

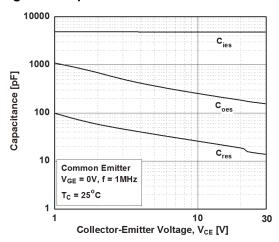


Figure 9. Turn-on Characteristics vs.
Gate Resistance

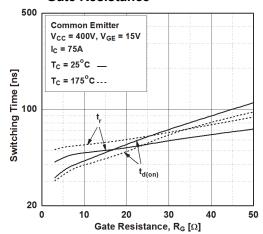


Figure 11. Switching Loss vs.
Gate Resistance

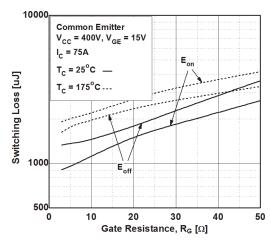


Figure 8. Gate charge Characteristics

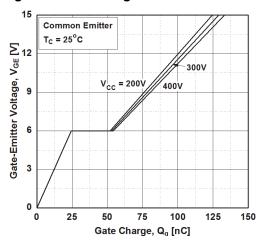


Figure 10. Turn-off Characteristics vs.
Gate Resistance

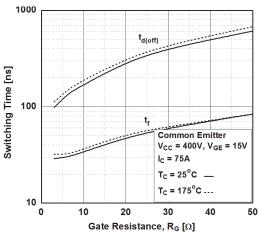


Figure 12. Turn-on Characteristics vs. Collector Current

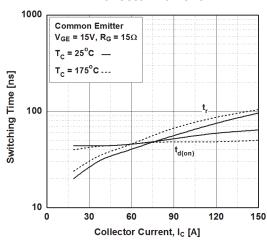


Figure 13. Turn-off Characteristics vs. Collector Current

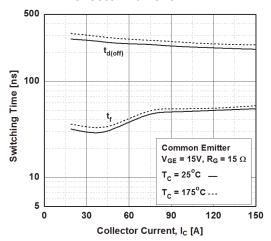


Figure 15. Load Current Vs. Frequency

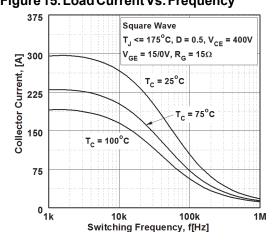


Figure 17. Forward Characteristics

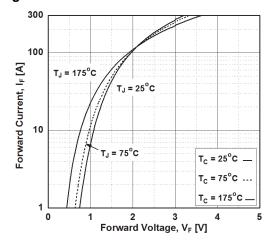


Figure 14. Switching Loss vs. Collector Current

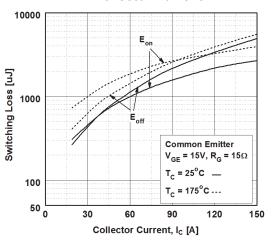


Figure 16. SOA Characteristics

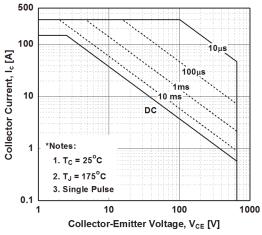


Figure 18. Reverse Recovery Current

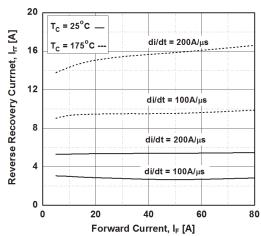


Figure 19. Reverse Recovery Time

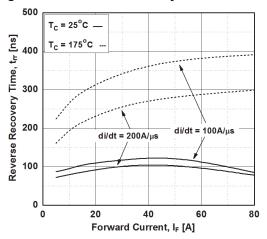


Figure 20. Stored Charge

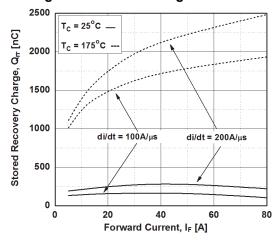


Figure 21.Transient Thermal Impedance of IGBT

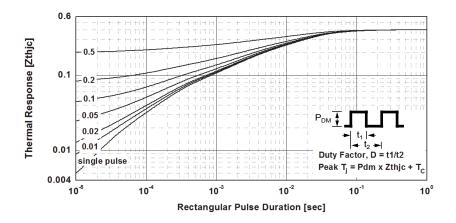
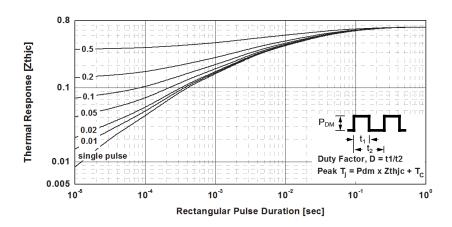
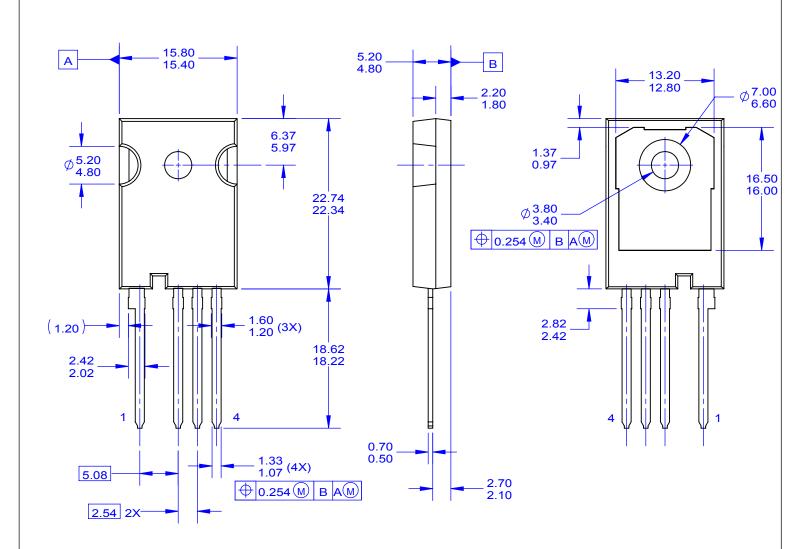


Figure 22. Transient Thermal Impedance of Diode





#### **NOTES:**

- A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5-2009.
- F. DRAWING FILENAME; MKT-TO247A04\_REV02.



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdt/Patent-Marking.pdf">www.onsemi.com/site/pdt/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and exp

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative